

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. .... 10/756,621  
Filing Date ..... January 12, 2004  
Inventor ..... Cem Basceri et al.  
Assignee ..... Micron Technology, Inc.  
Priority Group Art Unit ..... 2831  
Examiner ..... Unknown  
Attorney Docket No. .... MI22-2466  
Title: Methods of Forming Capacitor Constructions

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Commissioner for Patents  
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Dated: March 26, 2004By: Jaime White

Jaime White

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Although it is believed that no fees are due, the Commissioner is hereby authorized to charge any fees under 37 C.F.R. 1.16 and 1.17 which may be required by this paper to Deposit Account No. 23-0925.

Dated: 3/26/04By: David G. Latwesen

David G. Latwesen, Ph.D.

Reg. No. 38,533

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Inventor: Cem Basceri et al.

Title: Methods of Forming Capacitor Constructions

Assignee: Micron Technology, Inc.

**OFFICIAL****INFORMATION DISCLOSURE STATEMENT****References – See Attached Form PTO-1449**

The attached form PTO-1449 is submitted in compliance with 37 CFR § 1.56. Copies of the cited art are included with the exception of U.S. patents and published U.S. applications (1276 Off. Gaz. Pat. Off. 55, 05 August 2003). No admission is made regarding whether all the submitted references are prior art.

Respectfully submitted,

Dated: 3/26/04By: 

David G. Latwesen, Ph.D.

Reg. No. 38,533

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. M122-2466		SERIAL NO. 10756,621	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Cem Basceri et al.			
					FILING DATE January 12, 2004		PRIORITY GROUP 2831	
U.S. PATENT DOCUMENTS								
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate		
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	AO							
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	AK							
	AS							
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		Document Number	Date	Country	Class	Subclass	Translation Yes No
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	AN						
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	AP						
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